Application/Control No. Applicant(s)/Patent Under Reexamination MORGAN ET AL. Examiner Kevin M. Nguyen Applicant(s)/Patent Under Reexamination MORGAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,222,515	04-2001	Yamaguchi et al.	345/89
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